



N-CHANNEL ENHANCEMENT MODE MOSFET

Product Summary

| BV _{DSS} | R _{DS(ON)} | I _D T _A = +25°C |
|-------------------|-------------------------------|--|
| 12V | $23m\Omega$ @ $V_{GS} = 4.5V$ | 5.1A |
| 120 | $29m\Omega$ @ $V_{GS} = 2.5V$ | 4.8A |

Description

This new generation MOSFET has been designed to minimize the onstate resistance ($R_{DS(ON)}$) and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

Applications

- Battery Management
- Load Switch
- Battery Protection

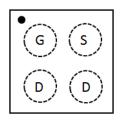
Features and Benefits

- Low Q_g & Q_{gd}
- Small Footprint
- Low Profile 0.62mm Height
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)

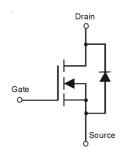
Mechanical Data

- Case: U-WLB1010-4 (Type C)
- Terminal Connections: See Diagram Below
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminal: Finish SnAgCu. Solderable per MIL-STD-202 Method 208 @1

U-WLB1010-4 (Type C)







Equivalent Circuit

Ordering Information (Note 4)

| Part Number | Case | Packaging |
|---------------|----------------------|------------------|
| DMN1023UCB4-7 | U-WLB1010-4 (Type C) | 3000/Tape & Reel |

Notes: 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS), 2011/65/EU (RoHS 2) & 2015/863/EU (RoHS 3) compliant.

- See https://www.diodes.com/quality/lead-free/ for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. For packaging details, go to our website at https://www.diodes.com/design/support/packaging/diodes-packaging/.

Marking Information



1A = Product Type Marking Code YM = Date Code Marking Y or \overline{Y} = Year (ex: F = 2018) M or \overline{M} = Month (ex: O = October)

Date Code Key

| Year | 201 | 5 | 2016 | | 2017 | 20 | 18 | 2019 | | 2020 | 2 | 2021 |
|-------|-----|-----|------|-----|------|-----|-----|------|-----|------|-----|------|
| Code | С | | D | | Е | F | = | G | | Н | | 1 |
| Month | Jan | Feb | Mar | Apr | May | Jun | Jul | Aug | Sep | Oct | Nov | Dec |
| Code | 1 | 2 | 3 | 4 | 5 | 6 | 7 | 8 | 9 | 0 | N | D |



| Characteristic | Symbol | Value | Unit | | |
|--|------------------|--|----------------|------------|---|
| Drain-Source Voltage | V _{DSS} | 12 | V | | |
| Gate-Source Voltage | V_{GSS} | ±8 | V | | |
| Continuous Drain Current (Note 5) V _{GS} = 4.5V | Steady State | $T_A = +25^{\circ}C$ $T_A = +70^{\circ}C$ | I _D | 5.1 4.1 | А |
| Continuous Drain Current (Note 5) V _{GS} = 2.5V | I _D | 4.8 3.9 | А | | |
| Pulsed Drain Current (Note 6) | I _{DM} | 15 | Α | | |

Thermal Characteristics

| Characteristic | Symbol | Value | Unit |
|--|-----------------------------------|-------------|------|
| Power Dissipation (Note 7) | PD | 0.8 | W |
| Thermal Resistance, Junction to Ambient @T _A = +25°C (Note 7) | R _{θJA} | 149 | °C/W |
| Power Dissipation (Note 5) | P _D | 1.2 | W |
| Thermal Resistance, Junction to Ambient @T _A = +25°C (Note 5) | R _{θJA} | 102 | °C/W |
| Operating and Storage Temperature Range | T _J , T _{STG} | -55 to +150 | °C |

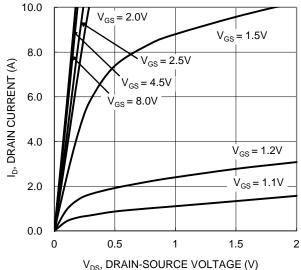
Electrical Characteristics (@T_A = +25°C, unless otherwise specified.)

| Characteristic | Symbol | Min | Тур | Max | Unit | Test Condition | |
|--|---------------------|-----|------|------|------|---|--|
| OFF CHARACTERISTICS (Note 8) | | | | | | | |
| Drain-Source Breakdown Voltage | BV _{DSS} | 12 | _ | _ | V | $V_{GS} = 0V, I_D = 250\mu A$ | |
| Zero Gate Voltage Drain Current T _J = +25°C | I _{DSS} | _ | _ | 1.0 | μA | $V_{DS} = 9.6V, V_{GS} = 0V$ | |
| Gate-Source Leakage | I _{GSS} | _ | _ | ±100 | nA | $V_{GS} = \pm 8V$, $V_{DS} = 0V$ | |
| ON CHARACTERISTICS (Note 8) | | | | | | | |
| Gate Threshold Voltage | V _{GS(TH)} | 0.4 | 0.7 | 1.2 | V | $V_{DS} = V_{GS}, I_D = 250 \mu A$ | |
| | | _ | 18 | 23 | mΩ | V _{GS} = 4.5V, I _D =1A | |
| Static Drain-Source On-Resistance | R _{DS(ON)} | _ | 22 | 29 | | $V_{GS} = 2.5V, I_D = 1A$ | |
| | | _ | 29 | 42 | | V _{GS} = 1.8V, I _D = 1A | |
| Forward Transfer Admittance | Y _{fs} | _ | 8 | _ | S | $V_{DS} = 6V$, $I_D = 1A$ | |
| Diode Forward Voltage | V _{SD} | _ | 0.7 | 1.0 | V | V _{GS} = 0V, I _S = 1A | |
| Reverse Recovery Charge | Q _{RR} | _ | 1.3 | _ | nC | $V_{DD} = 6V, I_F = 1A,$ | |
| Reverse Recovery Time | t _{RR} | _ | 11.2 | _ | ns | di/dt =100A/µs | |
| DYNAMIC CHARACTERISTICS (Note 9) | • | | | | | • | |
| Input Capacitance | Ciss | _ | 288 | 440 | | | |
| Output Capacitance | Coss | _ | 204 | 310 | pF | $V_{DS} = 6V$, $V_{GS} = 0V$, f = 1.0MHz | |
| Reverse Transfer Capacitance | C _{rss} | _ | 20 | 30 | | I = I.OWIHZ | |
| Series Gate Resistance | R_{G} | _ | 3.3 | 6.6 | Ω | f=1MHz,V _{GS} =0V, V _{DS} =0V | |
| Total Gate Charge | Qg | _ | 2.3 | 3.0 | | | |
| Gate-Source Charge | Q _{gs} | _ | 0.27 | _ | | $V_{GS} = 4.5V, V_{DS} = 6V,$ | |
| Gate-Drain Charge | Q _{gd} | _ | 0.15 | _ | nC | I _D =1A | |
| Gate Charge at V _{TH} | Q _{g(TH)} | _ | 0.13 | _ | | | |
| Turn-On Delay Time | t _{D(ON)} | _ | 3 | 5 | | | |
| Turn-On Rise Time | t _R | _ | 6 | _ | 20 | $V_{DS} = 6V, V_{GS} = 4.5V,$ | |
| Turn-Off Delay Time | t _{D(OFF)} | _ | 18 | 27 | ns | $R_G = 20\Omega$, $I_D = 1A$ | |
| Turn-Off Fall Time | t _F | _ | 9 | _ | | | |

Notes:

- Device mounted on FR-4 material with 1-inch² (6.45-cm²), 2-oz. (0.071-mm thick) Cu.
 Repetitive rating, pulse width limited by junction temperature.
 Device mounted on FR-4 PCB with minimum recommended pad layout, single sided.
 Short duration pulse test used to minimize self-heating effect.
 Guaranteed by design. Not subject to production testing.





V_{DS}, DRAIN-SOURCE VOLTAGE (V) Figure 1.Typical Output Characteristic

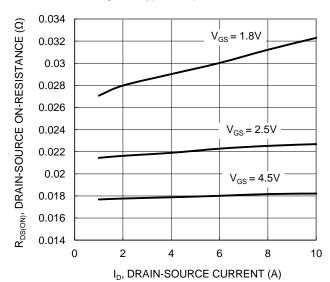


Figure 3. Typical On-Resistance vs. Drain Current and Gate Voltage

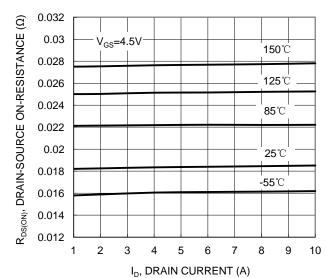
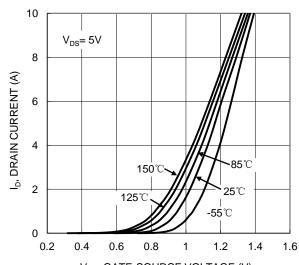


Figure 5. Typical On-Resistance vs. Drain Current and Junction Temperature



V_{GS}, GATE-SOURCE VOLTAGE (V) Figure 2. Typical Transfer Characteristic

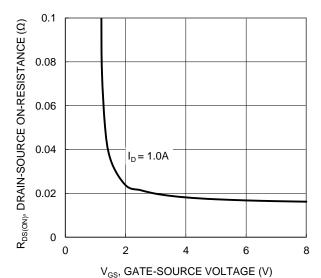


Figure 4. Typical Transfer Characteristic

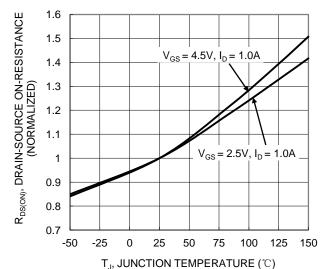
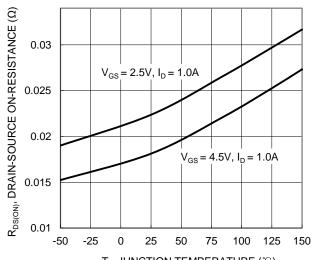


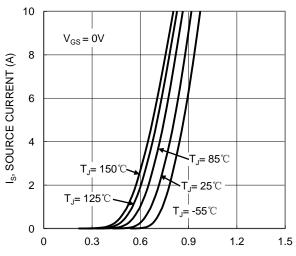
Figure 6. On-Resistance Variation with Junction
Temperature



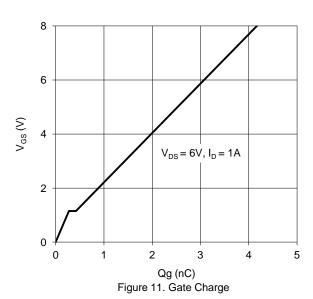




 $\mathsf{T_J},\mathsf{JUNCTION}$ TEMPERATURE (°C) Figure 7. On-Resistance Variation with Junction Temperature



 V_{SD} , SOURCE-DRAIN VOLTAGE (V) Figure 9. Diode Forward Voltage vs. Current



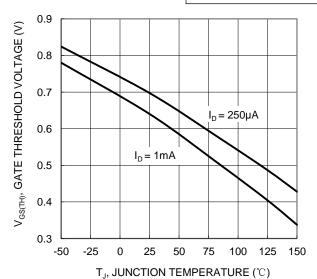
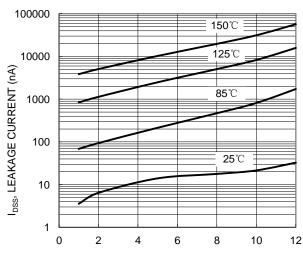
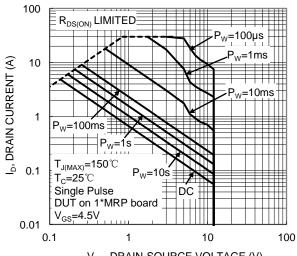


Figure 8. Gate Threshold Variation vs. Junction Temperature



 V_{DS} , DRAIN-SOURCE VOLTAGE (V) Figure 10. Typical Drain-Source Leakage Current vs. Voltage



V_{DS}, DRAIN-SOURCE VOLTAGE (V) Figure 12. SOA, Safe Operation Area



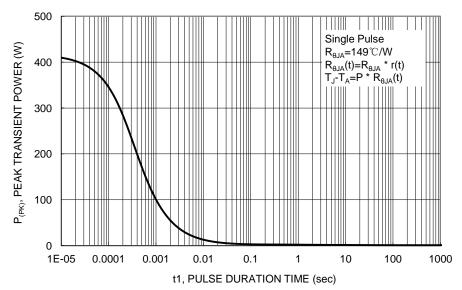


Figure 13. Single Pulse Maximum Power Dissipation

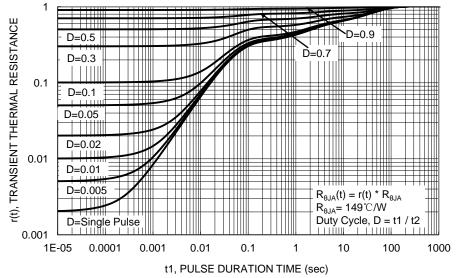


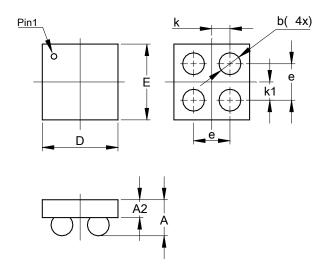
Figure 14. Transient Thermal Resistance



Package Outline Dimensions

Please see http://www.diodes.com/package-outlines.html for the latest version.

U-WLB1010-4 (Type C)

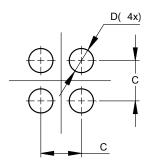


| U-WLB1010-4 (Type C) | | | | | | | |
|-------------------------|-------------------------|------|------|--|--|--|--|
| Dim | Dim Min Max Typ | | | | | | |
| Α | | 0.62 | | | | | |
| A2 | | | 0.38 | | | | |
| b | 0.25 | 0.35 | 0.30 | | | | |
| D | 0.92 | 1.00 | 0.96 | | | | |
| E | E 0.92 1.00 0.96 | | | | | | |
| е | e 0.50 | | | | | | |
| k | k 0.25 | | | | | | |
| k1 | | | 0.25 | | | | |
| All Dimensions in mm | | | | | | | |

Suggested Pad Layout

 $Please \ see \ http://www.diodes.com/package-outlines.html \ for \ the \ latest \ version.$

U-WLB1010-4 (Type C)



| Dimensions | Value (in mm) |
|------------|---------------|
| С | 0.500 |
| D | 0.300 |



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